



SHEET 1 OF 1

INFORMATION DISCLOSURE  
CITATION IN AN  
APPLICATIONATTY. DOCKET NO.  
71025-011SERIAL NO.  
10/828,553APPLICANT  
Yasuhiro ONO, et al.FILING DATE  
April 21, 2004GROUP  
1795

(PTO-1449)

## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code <sup>1</sup> -Number <sup>1</sup> -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
/A.H./		JP 2001-189495 A	7-10-2001	YAMAGUCHI INDUSTRIAL PROMOTION FOUNDATION		JAPAN (w/English Abstract)	
/A.H./		JP 8-37324 A	2-6-1996	SEIKO INSTR INC		JAPAN (w/English Abstract)	
/A.H./		JP 8-32127 A	2-2-1996	SEIKO INSTR INC		JAPAN (w/English Abstract)	

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	
/A.H./		TOBOLA et al. "Crossover from semiconductor to magnetic metal in semi-Heusler phases as a function of valence electron concentration", J. Phys.: Condens. Matter 10 (1998), pp 1013-1032	

EXAMINER

/Asha Hall/

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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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